

**Notice of References Cited**

Application/Control No.

10/572,527

Applicant(s)/Patent Under  
Reexamination  
SHIM, SOON-TEAK

Examiner

Brian Ensey

Art Unit

2615

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,239,945	12-1980	Atoji et al.	381/371
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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